Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10517213	YAMANE, MITOKU
Examiner	Art Unit
Quoc A Tran	2176

SEARCHED					
Class	Subclass	Date	Examiner		
715	262, 700	3/27/2008	QT		
455	90.3	3/27/2008	QT		
341	28	3/27/2008	QT		
345	168-169	3/27/2008	QT		
704	2	3/27/2008	QT		
Updated	Updated	9/29/2008	QT		

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPAT, USPGPUB, JPO, USOCR, FPRS, EPO, DERWENT & IBM_TDB)	3/27/2008	QT
Inventors Searched Conducted- Considered Double Patent Rejection	3/27/2008	QT
NPL Search (ACM Digital Library)	3/27/2008	QT
Text Search Class 715/262, 700; 455/All; 345/168-169; 704/2;	3/27/2008	QT
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INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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